Se	earch	Notes	•

Application/Control No.	Applicant(s)/Patent under Reexamination
10/808,405	IIJIMA ET AL.
Examiner	Art Unit
Mike Qi	2871

	SEARCHED			
Class	Subclass	Date	Examiner	
349	114,113; 44,146; 61,143	6/6/2006	zqq	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
East search US-PGPUB;USPAT;USOCR; EPO;JPO;DERWENT;IBM_TDB; update search; (see ssearch history printout)	6/6/2006	ZQQ
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